

Search Notes

Application/Control No.

09/925,155

Examiner

Tan V. Mai

Applicant(s)/Patent under
Reexamination

PURCELL ET AL.

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
708	300, 256, 253	7/1/2005	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see attached copy) Check references of Div. 10/711,115	7/1/2005	MAI